

(Use several sheets if necessary)

SERIAL NO. 09/639,870

**Applicants: Michael A. DeJack et al.**

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**August 16, 2000**

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## PATENT DOCUMENTS

[illegible]

## FOREIGN PATENT DOCUMENTS

[illegible]

**OTHER DOCUMENTS** (Including Author, Title, Date, Pertinent Pages, Etc.)

KW		Lafon, "Solid Modeling With Constraints and Parameterised Features", IEEE, July 1998.
KW		Jinsong et al., "Parametric Design with Intelligence Configuration Analysis Mechanism", IEEE, November 1993.
KW		Mateos et al., "Parametric and Associative Design of Cartridges for Special Tools", IEEE 1995.

**EXAMINER**

**DATE CONSIDERED**

11/26/03

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Form PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 199-1164/DBK		SERIAL NO.		1c864 U.S. PTO 09/639870 08/16/00						
INFORMATION DISCLOSURE STATEMENT BY APPLICANT		APPLICANT: David G. Strenski, et al.										
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U.S. PATENT DOCUMENTS												
Examiner Initial	Document No.							Date	Name	Class	Sub- Class	Filing Date
KW	5	0	7	0	5	3	4	12/3/91	Lascelles et al.	345	764	
KW	5	1	1	1	4	1	3	5/5/92	Lazsansky et al.	703	14	
KW	5	1	9	7	1	2	0	3/23/93	Saxton et al.	345	661	
FOREIGN PATENT DOCUMENTS												
	Document No.							Date	Country	Class	Sub- Class	Transl. Yes No
OTHER DOCUMENTS (Incl. Author, Title, Date, Pertinent Pages, etc.)												
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